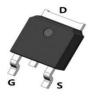
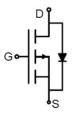


Main Product Characteristics:

V _{DSS}	-30V
R _{DS} (on)	7.8mΩ (typ.)
I _D	-40A





TO-252

Schematic Diagram

Features and Benefits:

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature



Description:

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

Absolute Max Rating:

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V ①	-40	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V ①	-25	Α
I _{DM}	Pulsed Drain Current ②	-160	
P _D @T _C = 25°C	Power Dissipation ③	62	W
V _{DS}	Drain-Source Voltage	-30	V
V _{GS}	Gate-to-Source Voltage	± 20	V
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C



Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
Rejc	Junction-to-Case ③	_	2	°C/W

Electrical Characterizes @T_A=25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source breakdown voltage	-30	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$
В	Static Drain-to-Source on-resistance	_	7.8	10.5	m0	V _{GS} = -10V,I _D = -30A
$R_{DS(on)}$	Static Drain-to-Source on-resistance	_	10.5	14	mΩ	V _{GS} = -4.5V,I _D = -15A
$V_{GS(th)}$	Gate threshold voltage	-1.4	_	-2.4	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
I _{DSS}	Drain-to-Source leakage current	_	_	-1	μA	$V_{DS} = -30V, V_{GS} = 0V$
1	Cata to Source forward looked	_	_	100	n 1	V _{GS} =20V
I _{GSS}	Gate-to-Source forward leakage	_	_	-100	nA	V _{GS} = -20V
C _{iss}	Input capacitance	_	1790	_		V _{GS} = 0V
Coss	Output capacitance	_	320	_	pF	V _{DS} = -15V
Crss	Reverse transfer capacitance	_	260	_		f = 1MHz
Qg	Total gate charge	_	30	_		I _D = -30A,
Qgs	Gate-to-Source charge	_	5	_	nC	V _{DS} = -15V,
Q _{gd}	Gate-to-Drain("Miller") charge	_	7	_		V _{GS} = -10V
t _{d(on)}	Turn-on delay time	_	15	_		
t _r	Rise time	_	20	_		V_{GS} = -10V, V_{DS} = -15V,
t _{d(off)}	Turn-Off delay time	_	95	_	ns	$R_{GEN}=3\Omega, I_D=-30A$
t _f	Fall time	_	65	_		

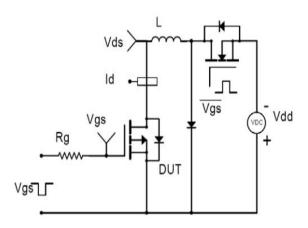
Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
	Continuous Source Current			40	^	MOSFET symbol □
l _S	(Body Diode)	_	_	-40	A	showing the
	Pulsed Source Current			100	^	integral reverse
lsм	(Body Diode)	_	_	-160	A	p-n junction diode.
V _{SD}	Diode Forward Voltage	_	_	-1.2	V	I _S =-30A, V _{GS} =0V
t _{rr}	Reverse Recovery Time	_	20	_	ns	$T_J = 25^{\circ}C$, $I_F = -30A$, $di/dt =$
Q _{rr}	Reverse Recovery Charge	_	10	_	nC	100A/µs

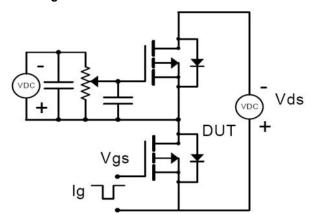


Test Circuits and Waveforms

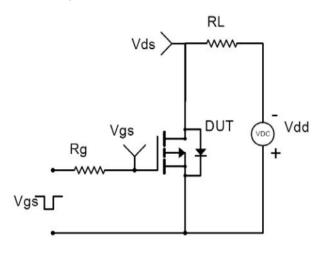
EAS Test Circuit:



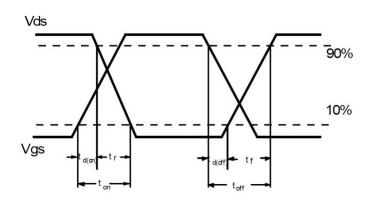
Gate Charge Test Circuit:



Switching Time Test Circuit:



Switching Waveforms:



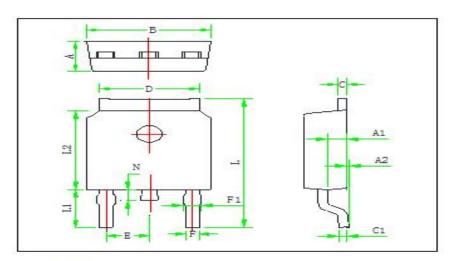
Version: Preliminary

Notes:

- ①Calculated continuous current based on maximum allowable junction temperature.
- ②Repetitive rating; pulse width limited by max. junction temperature.
- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.



Mechanical Data:



Symbol	Min	Typ	Max		
A	2.20	2.30	2.40		
A1	0.91	1.01	1.11		
A2	0.05	0.15	0.25		
В	6.45	6.60	6.75		
C	0.45	0.50	0.58		
C1	0.45	0.50	0.58		
D	5.12	5.32	5.52		
E	2.286 TYP				
F	0.66	0.76	0.86		
F1	0.66	0.86	1.06		
L	9.60	9.90	10.20		
L1	2.6	2.8	3.0		
L2	5.95	6.10	6.25		
N	0.60	0.80	1.00		





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